

Notice of References Cited	Application/Control No. 10/562,356		Applicant(s)/Patent Under Reexamination TAKASE ET AL.	
	Examiner EDMUND H. LEE		Art Unit 1791	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,652,799	11-2003	Seng et al.	264/511
*	B	US-2007/0138696	06-2007	Takase et al.	264/272.17
	C	US-			
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	F	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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